

## AW-29

### Gold Bonding Wire for Universal Use in Discrete and IC (Larger Dia) Applications



#### AW-29 Benefits

- Permits ease of looping for high loop applications
- Robust 2nd bond with wide application range for low temperature bonding, such as on soft substrate e. g. COB and Hybrids packages
- Established for use on sensitive IC die metallizations with wire diameter  $\geq 30 \mu\text{m}$
- Compatible with high speed automatic ball bonding equipment

Ideal for discrete devices such as LEDs, Optos etc, AW-29 is typically found in  $25 \mu\text{m}$  to  $35 \mu\text{m}$  diameters. This alloy displays salient characteristics via its long HAZ which facilitates ease of looping for both medium ( $\sim 170 \mu\text{m}$ )\* and high loop ( $\sim 230 \mu\text{m}$ )\* applications, thereby minimizing requirements on machine looping

capability. In addition, AW-29's large process 2nd bond window makes it an excellent choice for low temperature bonding on soft substrates. AW-29 is also commonly used on sensitive die metallization, even in diameters  $> 30 \mu\text{m}$ .

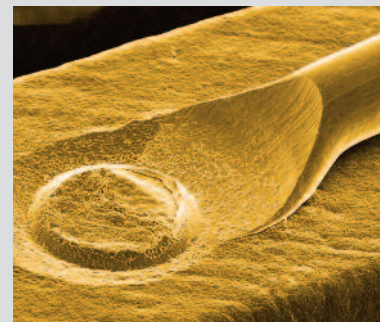
\* Reference to  $25 \mu\text{m}$  wire dia.

#### Application Data\*

First bond results on optimum setting

	Ball Diameter ( $\mu\text{m}$ )	Squash Height ( $\mu\text{m}$ )	Shear Force (g)	Shear Strength (g/mil <sup>2</sup> )
Mean	88	16	71.1	7.5
Std Dev	0.35	0.63	2.7	0.3
Min	84	13	66.0	6.5
Max	93	20	76.2	7.9

\*Results may vary with package and die configuration, as well as bond process.



Bonding Conditions: Wire diameter:  $33 \mu\text{m}$  · Wire bonder: K&S 1488 turbo  
 Package type: PLCC 68 leads · Die metallization: AlSi (1%), Cu (0.5%)  
 Leadframe: Ag-Plated Cu · Wire span: 3.2 – 4 mm · Loop height range:  $230 \mu\text{m} \pm 25 \mu\text{m}$   
 Bonding temperature:  $240^\circ\text{C}$  · Capillary: 41413-0013-335 ·  $T=3.7 \text{ mil}$ ,  $FA 8^\circ$

## AW-29 Mechanical Properties

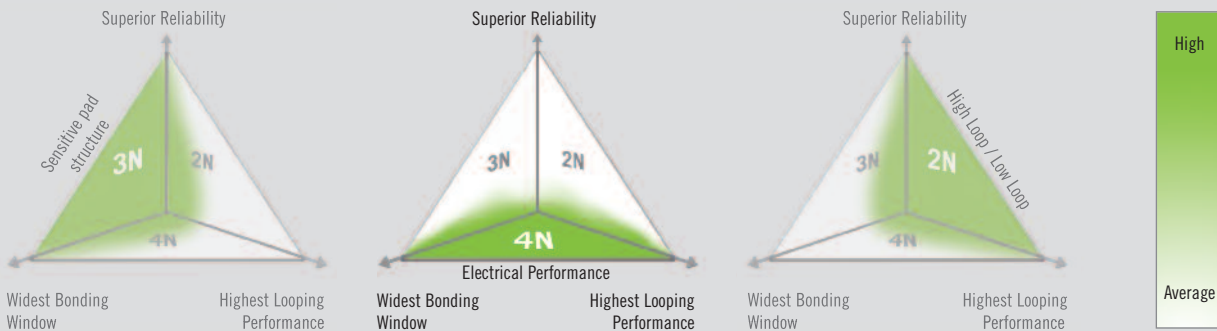
Diameter	Microns	20	23	25	28	30	32	33	38	50
	Mils	0.8	0.9	1.0	1.1	1.2	1.25	1.3	1.5	2.0
<b>Recommended Specs for Ball Bonding</b>										
Elongation (%)		2 – 6	2 – 6	2 – 6	2 – 6	2 – 7	2 – 7	2 – 7	2 – 7	4 – 12
Breaking Load (g)		3 – 8	4 – 9	7 – 11	8 – 14	9 – 16	12 – 19	13 – 20	19 – 25	30 – 45
<b>Typical Breaking Load (g)</b>										
Room Temp @ 4% EL		5.4	6.5	9.3	11.9	13.8	16.9	22.7	23.6	35.1*
High Temp (250°C/20s)		5.0	6.0	8.6	10.9	12.8	14.4	15.5	20.9	32.3

\* @ 8% EL

## AW-29 Characteristics (for 30 µm diameter wire)

Non-Gold Elements	< 100 ppm
Breaking Load @ Room Temperature	> 13 g at 4% EL
Breaking Load @ 250°C / 20 sec.	> 12 g
Elastic Modulus	> 65 GPa
Heat Affected Zone (HAZ)	~ 200 µm (for 70 µm ball diameter)
Neck Strength	~ 11 g (at 70 µm ball diameter)
Melting Point	1063°C
Density	19.32 g/cm <sup>3</sup>
Heat Conductivity	3.17 W/cm-K
Electrical Resistivity	2.3 µOhm-cm
Coeff. of Linear Expansion (0 – 100°C)	14.2 ppm / K
Fusing Current for 30 µm, dia 10 mm length (in air)	0.6 A

## Gold Wire Segmentation by Properties



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